

Supporting Information for:

**Unlocking Zeolite-Like structure as a New Family of Interstitial
Oxide Ion Conductors: Insights into Carrier Trapping, Collective
Local Distortion, and Correlated Disorder**

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Table S1. Calculated and experimental structural parameters for SrGa₂Ge₂O₈

Parameters	Calculated	Experimental	$\Delta(\text{Calc.}-\text{Exp.})$
a (Å)	9.2925	9.2100	0.0825
b (Å)	9.5857	9.6660	-0.0803
c (Å)	8.6515	8.5700	0.0815
$\alpha = \gamma$ (°)	90	90	0
β (°)	90.5154	90.5600	-0.446
Volume (Å ³)	770.6112	762.8980	7.7132
Sr1-O1 (Å)	2.9335	2.6472	0.2863
Sr1-O2 (Å)	2.9847	2.7056	0.2791
Sr1-O3 (Å)	3.3077	3.4740	-0.1663
Sr1-O3 (Å)	2.7673	2.6244	0.1429
Sr1-O4 (Å)	3.3357	3.4754	-0.1397
Sr1-O4 (Å)	2.8066	2.5893	0.2173
Sr1-O5 (Å)	2.7338	2.5807	0.1531
Sr1-O6 (Å)	2.7100	2.6016	0.1084
Sr1-O8 (Å)	2.8891	2.6219	0.2672
Ga1-O2 (Å)	1.6806	1.8406	-0.16
Ga1-O4 (Å)	1.6841	1.8367	-0.152
Ga1-O6 (Å)	1.6743	1.8290	-0.1547
Ga1-O7 (Å)	1.6395	1.8040	-0.1645
Ga2-O1 (Å)	1.6633	1.8209	-0.1576
Ga2-O3 (Å)	1.6825	1.8436	-0.1611
Ga2-O5 (Å)	1.6659	1.8140	-0.1481
Ga2-O8 (Å)	1.6620	1.8415	-0.1795
Ge1-O1 (Å)	1.7356	1.7566	-0.021
Ge1-O3 (Å)	1.7501	1.7481	0.002
Ge1-O5 (Å)	1.7346	1.7487	-0.0141
Ge1-O7 (Å)	1.7006	1.7343	-0.0337
Ge2-O2 (Å)	1.7205	1.7412	-0.0207
Ge2-O4 (Å)	1.7501	1.7652	-0.0151
Ge2-O6 (Å)	1.7240	1.7390	-0.015
Ge2-O8 (Å)	1.7308	1.7503	-0.0195

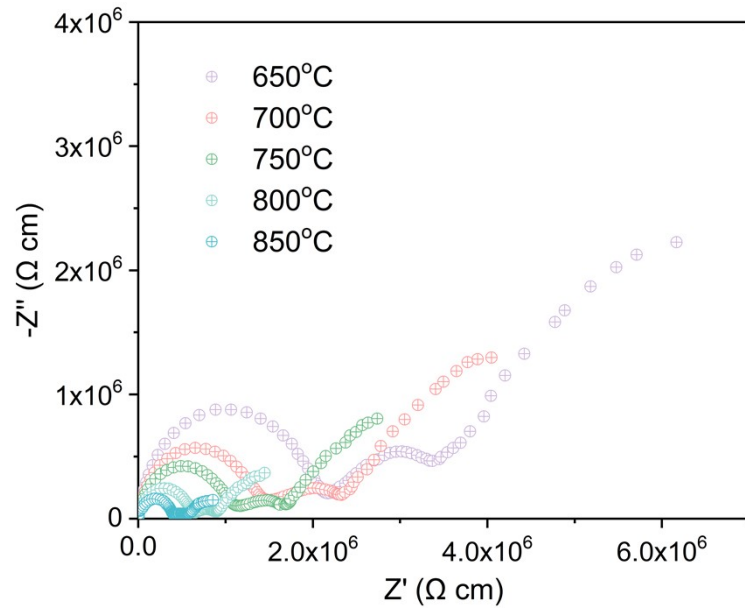


Figure S1. Complex impedance plots of $x = 0.15$ composition at different temperatures.

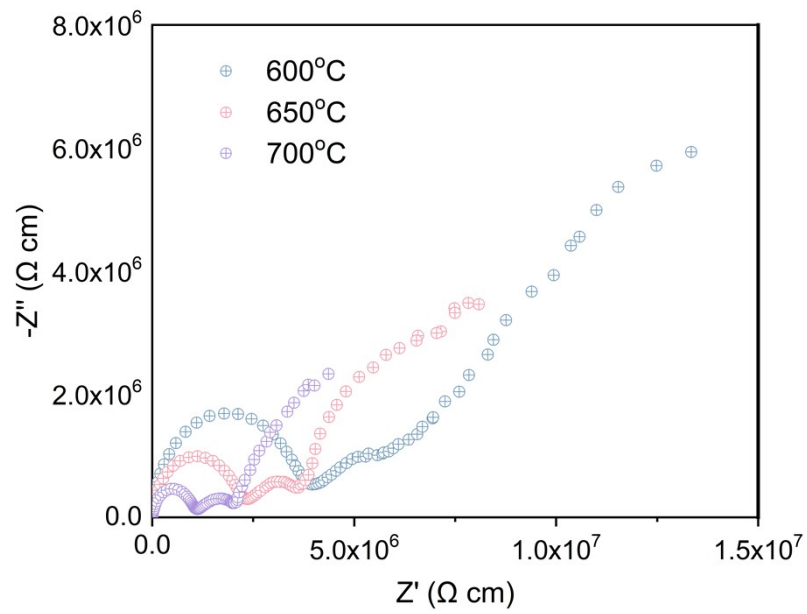


Figure S2. Complex impedance plots of $x = 0.05$ composition at different temperatures (600 °C, 650 °C, and 700 °C).

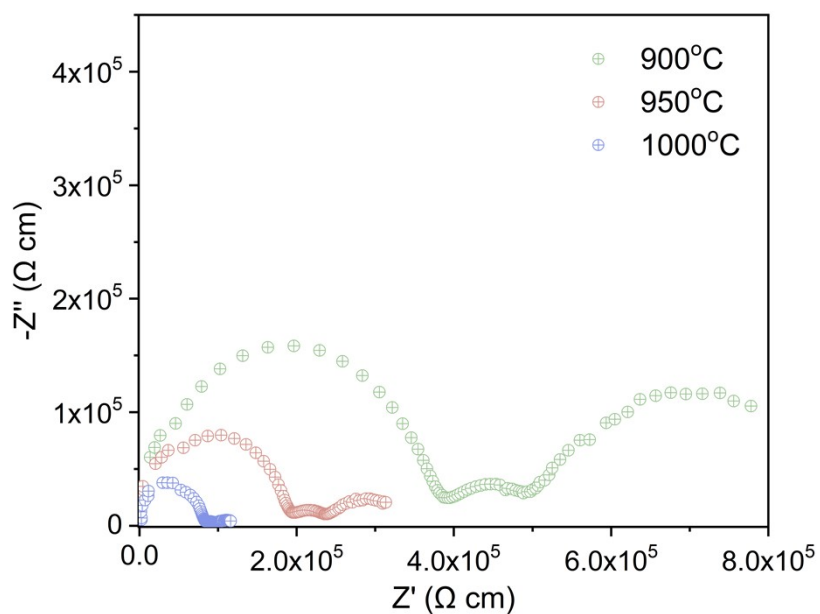


Figure S3. Complex impedance plots of $x = 0.05$ composition at different temperatures (900 °C, 950 °C, and 1000 °C).

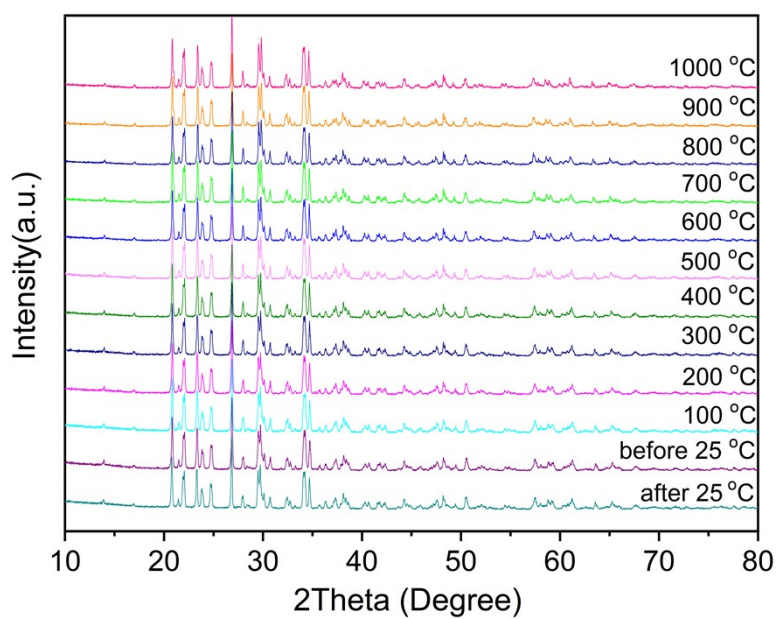


Figure S4. Variable temperature XRD patterns of $\text{Sr}_{0.85}\text{La}_{0.15}\text{Ga}_2\text{Ge}_2\text{O}_{8.075}$.

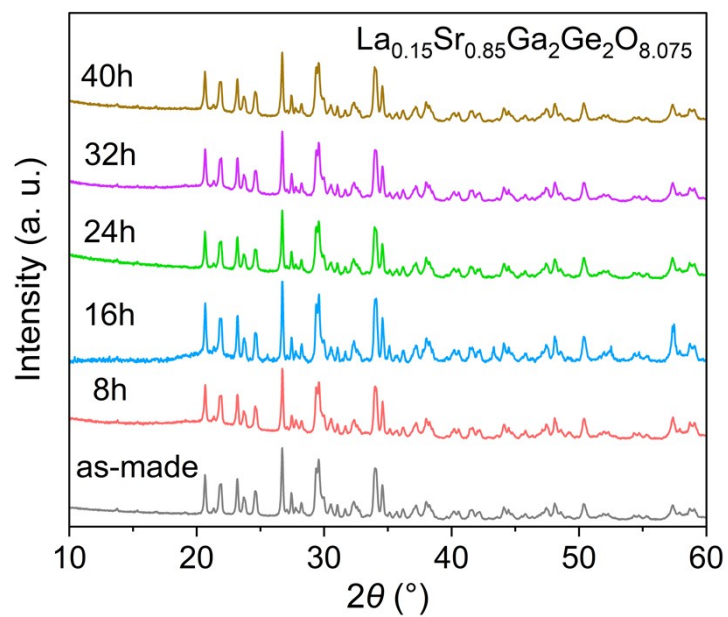


Figure S5. XRD patterns of $\text{Sr}_{0.85}\text{La}_{0.15}\text{Ga}_2\text{Ge}_2\text{O}_{8.075}$ reduced at 800°C for 8-40 h under a 5% H_2 -95% N_2 atmosphere.

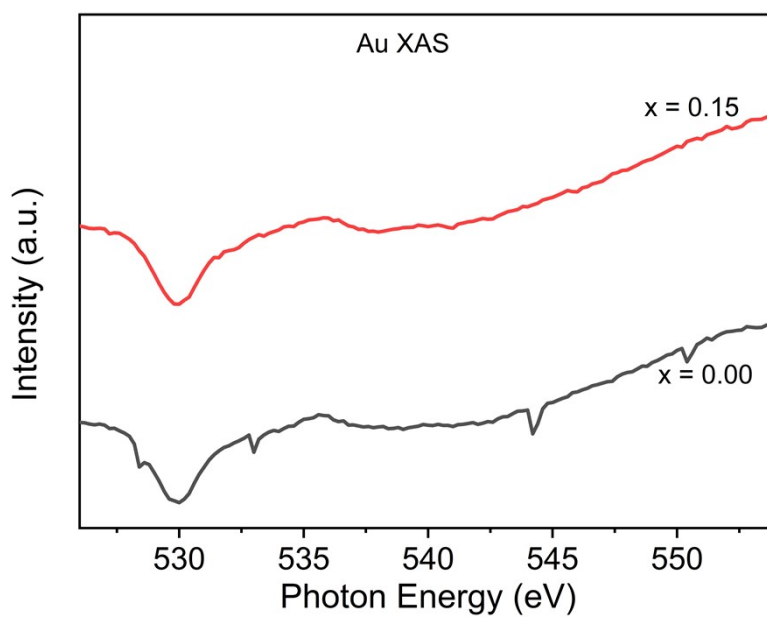


Figure S6. XAS spectra of Au as a reference to $\text{Sr}_{1-x}\text{La}_x\text{Ga}_2\text{Ge}_2\text{O}_{8+x/2}$.

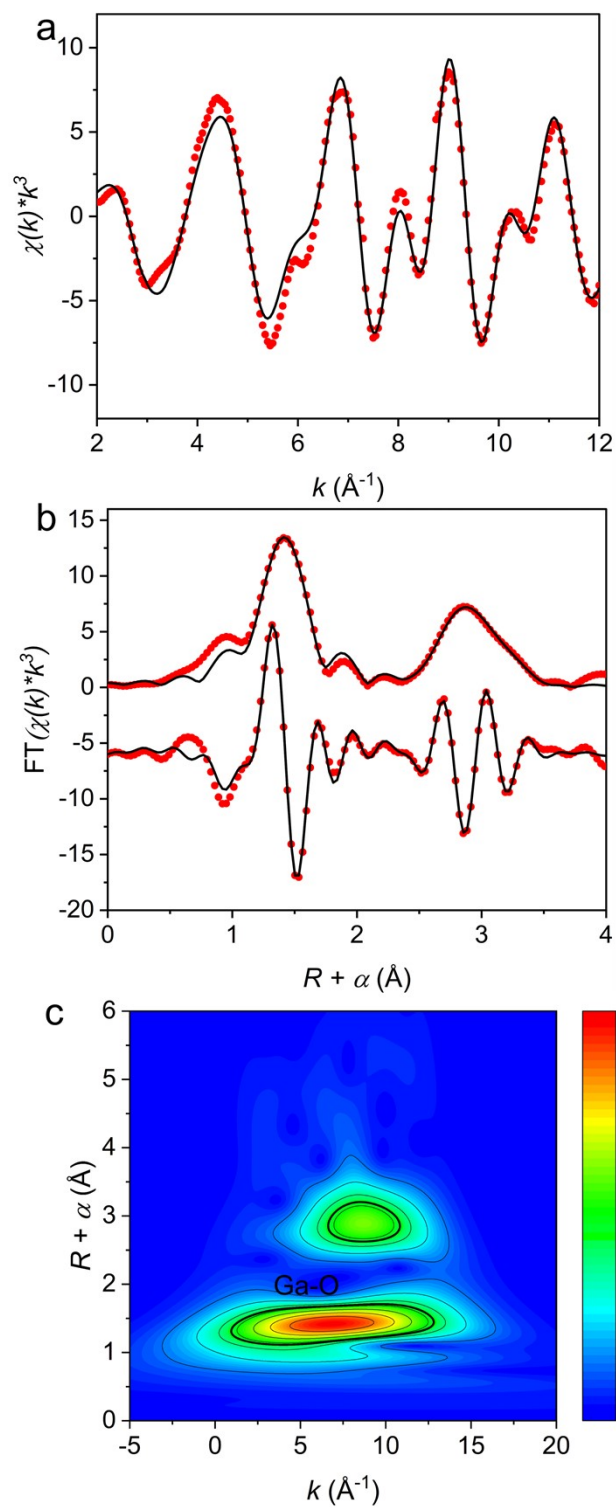


Figure S7. Fourier-transformed (FT) k^3 -weighted EXAFS (points) and curvefit (line) spectra in both (a) k -space and (b) R -space for parent $\text{SrGa}_2\text{Ge}_2\text{O}_8$. (c) Ga K-edge wavelet transform EXAFS contours of parent $\text{SrGa}_2\text{Ge}_2\text{O}_8$.

Table S2. Curvefit Parameters for Ga K-edge EXAFS for SrGa₂Ge₂O₈

Path	N	$R / \text{\AA}$	$d / \text{\AA}$	$\sigma^2 / \text{\AA}^2$
O5	4.0	1.83(1)	1.830	0.001
Sr1	1.0	3.46(1)	3.422	0.001
Ge1	3.0	3.13(1)	3.141	0.004
Ge2	1.0	2.51(1)	3.175	0.018
O1	18.0	3.64(1)	3.307	0.073

* S_0^2 was fixed as 0.776. ΔE_0 was refined as a global fit parameter, returning a value of (3 ± 1) eV. Data ranges: $2 \leq k \leq 12 \text{ \AA}^{-1}$, $1 \leq R \leq 3 \text{ \AA}$. The number of variable parameters is 12, out of a total of 15.7 independent data points. R factor for this fit is 0.9%.

Table S3. Curvefit Parameters for Ga K-edge EXAFS for La_{0.15}Sr_{0.85}Ga₂Ge₂O_{8.075}

Path	N	$R / \text{\AA}$	$d / \text{\AA}$	$\sigma^2 / \text{\AA}^2$
O5	4.0	1.84(1)	1.730	0.001
Oi	1.0	2.42(1)	2.292	0.006
Sr1	1.0	2.92(1)	2.994	0.002
Ge1	3.0	3.13(1)	3.081	0.001
Ge2	1.0	3.54(1)	3.244	0.001
O5	18.0	3.25(1)	3.249	0.006

* S_0^2 was fixed as 0.776. ΔE_0 was refined as a global fit parameter, returning a value of (7 ± 2) eV. Data ranges: $2 \leq k \leq 12 \text{ \AA}^{-1}$, $1 \leq R \leq 3 \text{ \AA}$. The number of variable parameters is 12, out of a total of 15.7 independent data points. R factor for this fit is 1.7%.

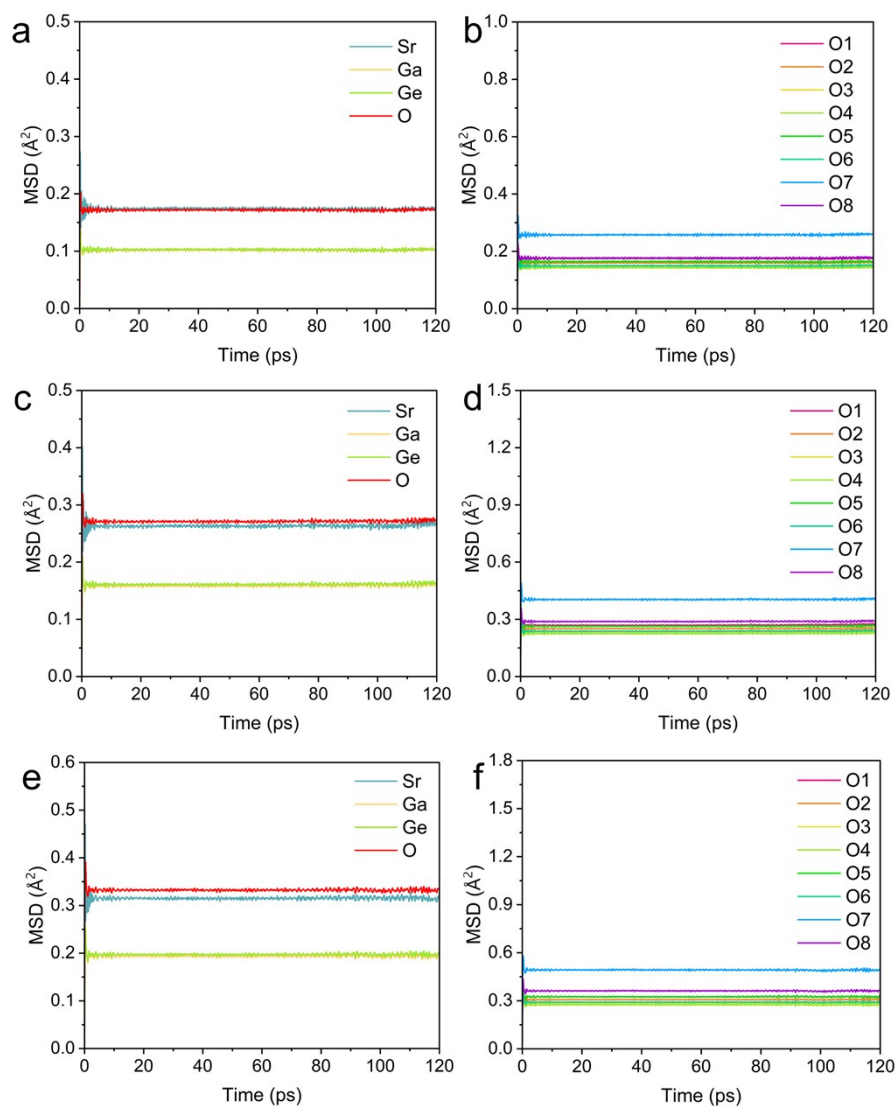


Figure S8. MSD values of Sr, Ga, Ge, and O in parent $\text{SrGa}_2\text{Ge}_2\text{O}_8$ at (a-b) 873 K, (c-d) 1273 K, and (e-f) 1473 K.

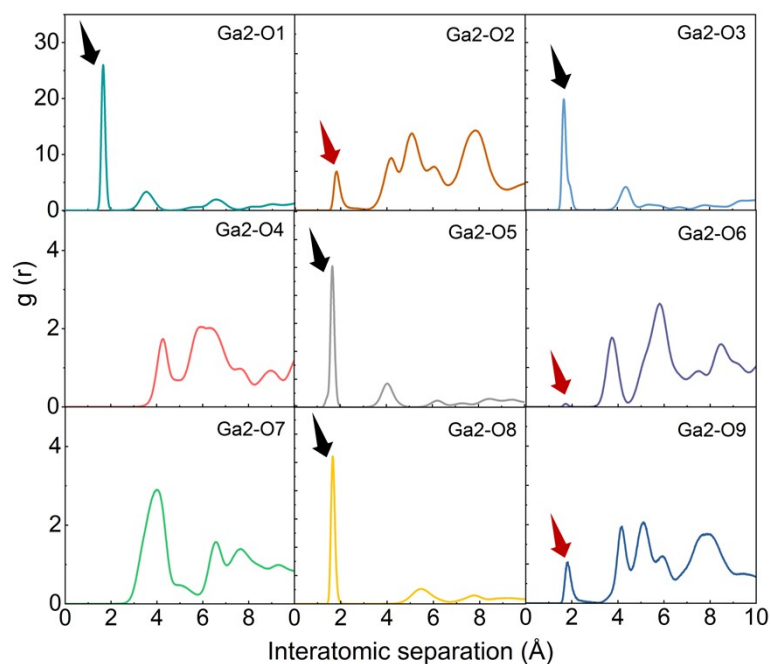


Figure S9. RDFs of Ga2-O interactions with simulation times, where the black and red arrows denote the interactions of Ga2 with the original site O (O1, O3, O5 and O8) and the derivative site O (O2, O6, and O9), respectively.

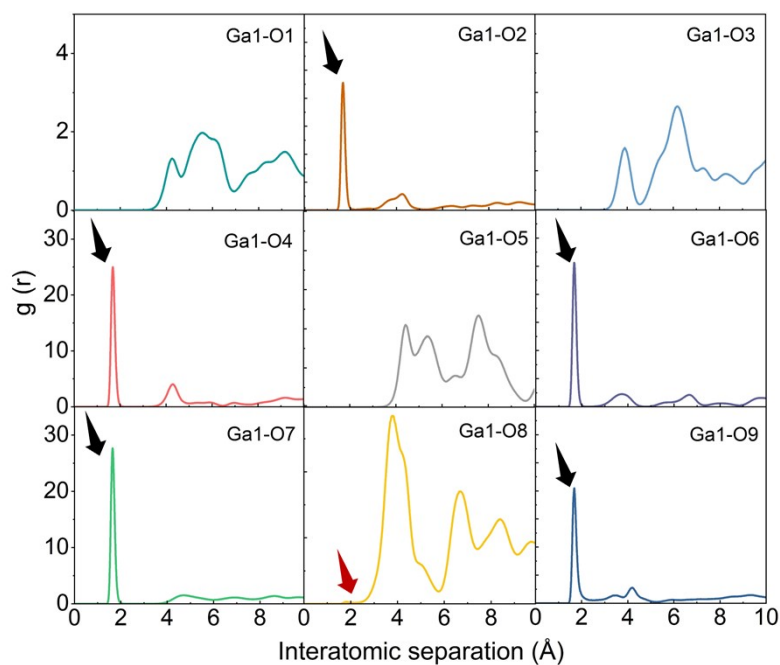


Figure S10. RDFs of Ga1-O interactions with the simulation time within the Ga1Ge2 layer, where the black arrows denote the interactions of Ga1 with the original site O (O2, O4, O6, O7 and O9).

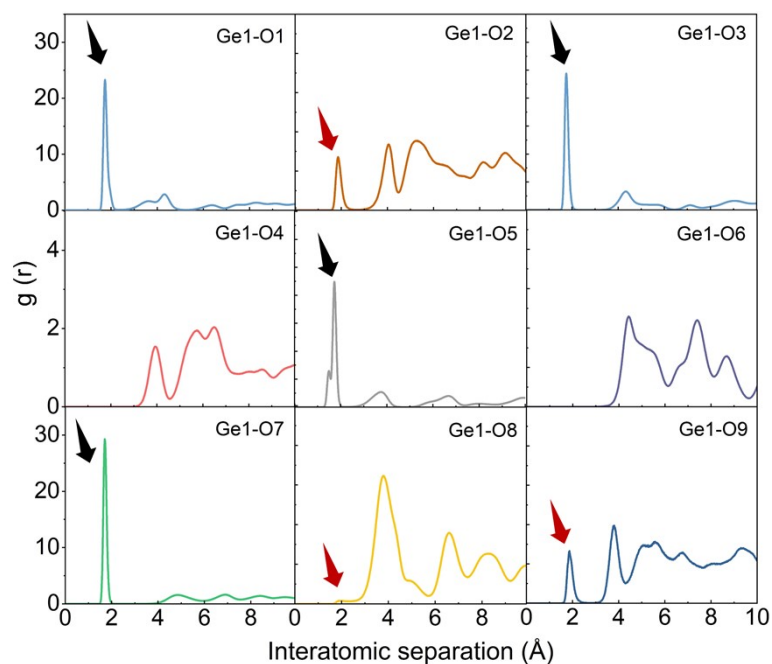


Figure S11. RDFs of Ge1-O interactions with the simulation time within the Ga1Ge2 layer, where the black and red arrows denote the interactions of Ge1 with the original site O (O1, O3, O5 and O7) and the derivative site O (O2 and O9), respectively.

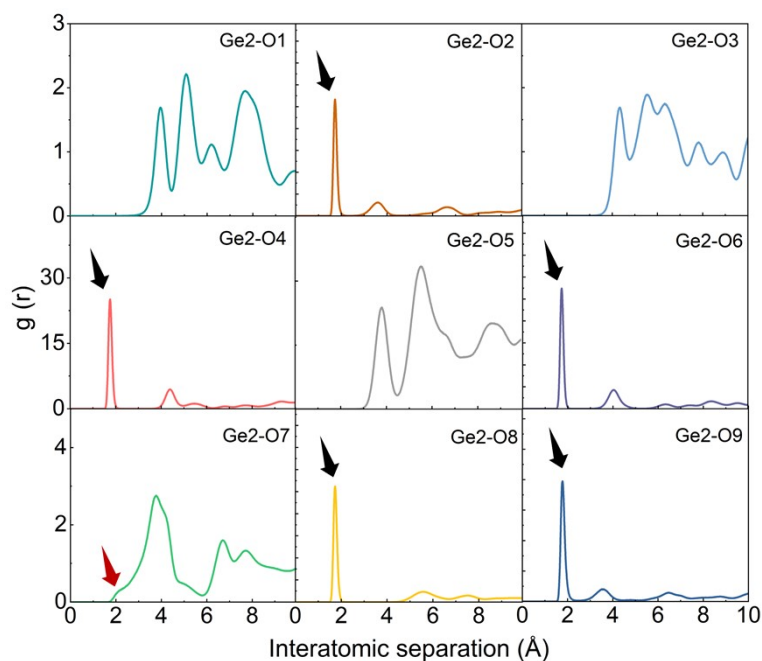


Figure S12. RDFs of Ge2-O interactions with the simulation time within the Ga1Ge2 layer, where the black arrows denote the interactions of Ge2 with the original site O (O2, O4, O6, O8 and O9).

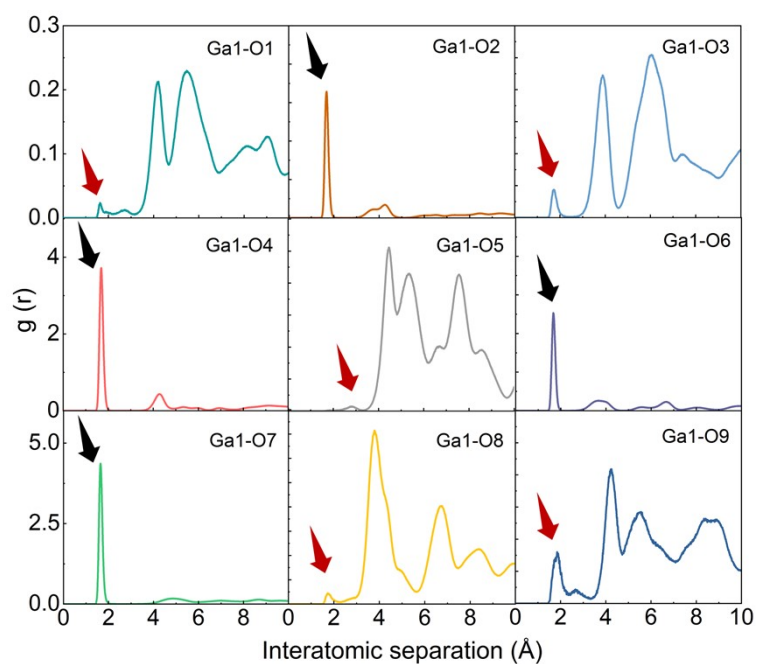


Figure S13. RDFs of Ga1-O interactions with the simulation time within the Ga2Ge1 layer, where the black and red arrows denote the interactions of Ga1 with the original site O (O2, O4, O6 and O7) and the derivative site O (O1, O3, O5, O8 and O9), respectively.

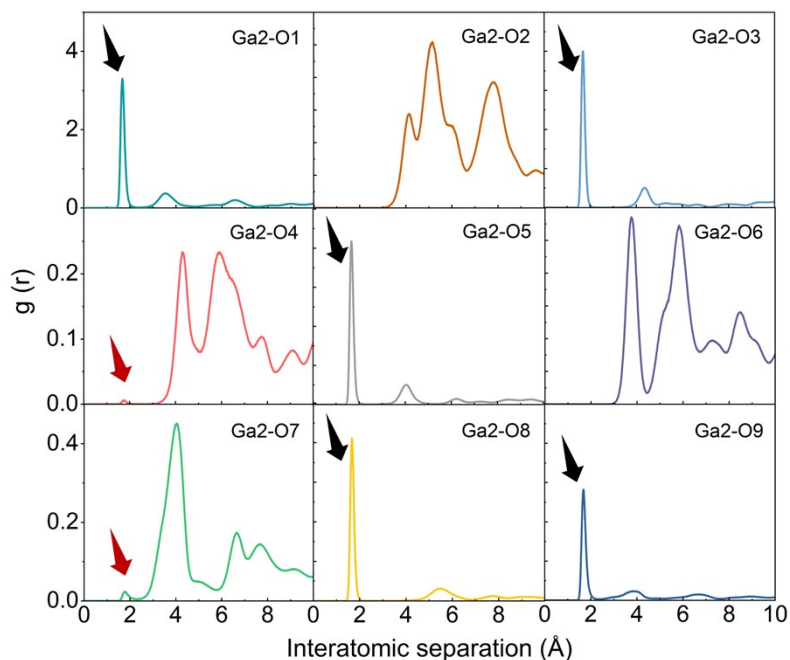


Figure S14. RDFs of Ga2-O interactions with the simulation time within the Ga2Ge1 layer, where the black and red arrows denote the interactions of Ga2 with the original site O (O1, O3, O5, O8 and O9) and the derivative site O (O2 and O7), respectively.

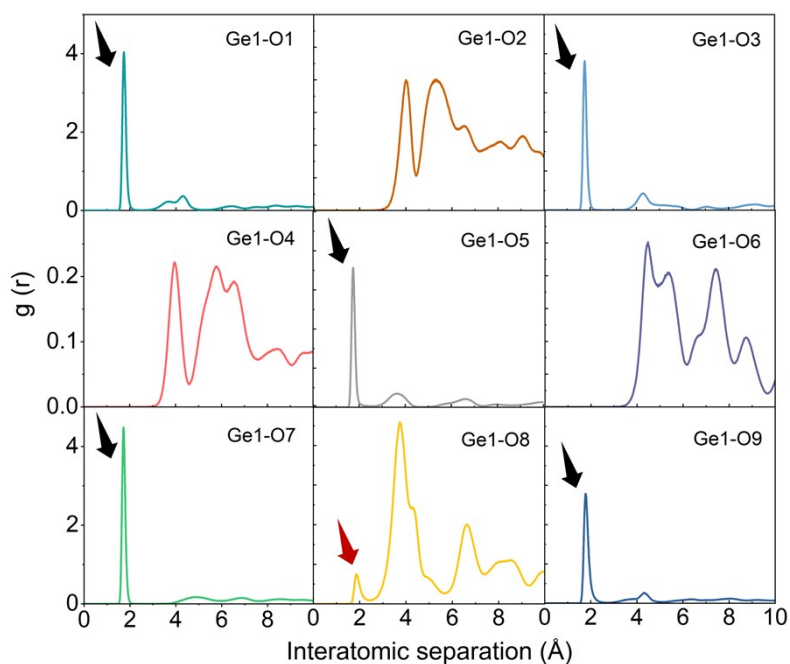


Figure S15. RDFs of Ge1-O interactions with the simulation time within the Ga2Ge1 layer, where the black and red arrows denote the interactions of Ge1 with the original site O (O1, O3, O5, O7 and O9) and the derivative site O (O8), respectively.

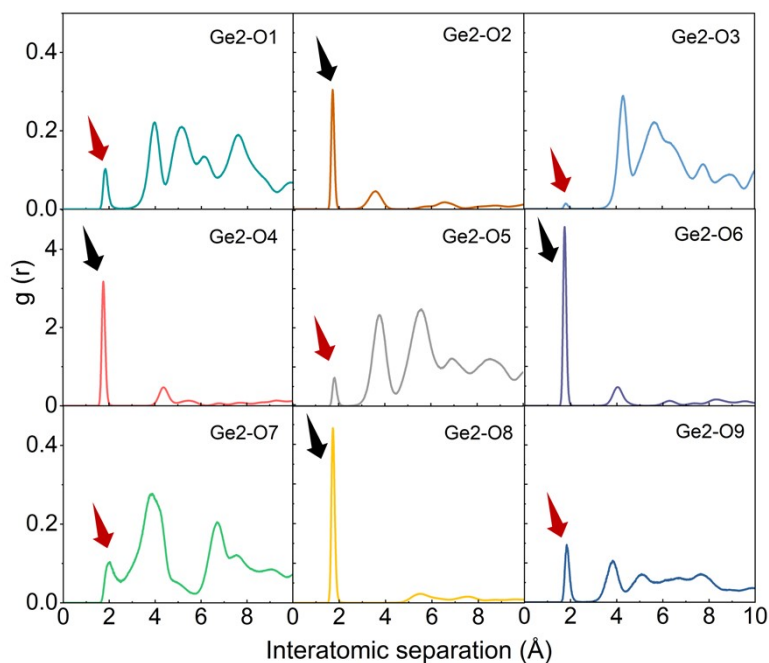


Figure S16. RDFs of Ge2-O interactions with the simulation time within the Ga2Ge1 layer, where the black and red arrows denote the interactions of Ge2 with the original site O (O2, O4, O6 and O8) and the derivative site O (O1, O3, O5, O7 and O9), respectively.